

# PMDT670UPE

# 20 V, 550 mA dual P-channel Trench MOSFET Rev. 1 — 13 September 2011

Product data sheet

### **Product profile**

### 1.1 General description

Dual P-channel enhancement mode Field-Effect Transistor (FET) in an ultra small and flat lead SOT666 Surface-Mounted Device (SMD) plastic package using Trench MOSFET technology.

### 1.2 Features and benefits

- Very fast switching
- Trench MOSFET technology
- ESD protection up to 2 kV
- AEC-Q101 qualified

### 1.3 Applications

- Relay driver
- High-speed line driver

- High-side loadswitch
- Switching circuits

### 1.4 Quick reference data

Table 1. Quick reference data

| Symbol            | Parameter                        | Conditions  |            | Min | Тур  | Max  | Unit |
|-------------------|----------------------------------|---|------------|-----|------|------|------|
| Per transisto     | or                               |   |            |     |      |      |      |
| $V_{DS}$          | drain-source voltage             | T <sub>j</sub> = 25 °C                                |            | -   | -    | -20  | V    |
| $V_{GS}$          | gate-source voltage              |   |            | -8  | -    | 8    | V    |
| $I_D$             | drain current                    | $V_{GS} = -4.5 \text{ V}; T_{amb} = 25 \text{ °C}$    | <u>[1]</u> | -   | -    | -550 | mA   |
| Static charac     | cteristics (per transistor)      |   |            |     |      |      |      |
| R <sub>DSon</sub> | drain-source on-state resistance | $V_{GS}$ = -4.5 V; $I_{D}$ = -400 mA; $T_{j}$ = 25 °C |            | -   | 0.67 | 0.85 | Ω    |

<sup>[1]</sup> Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 1 cm<sup>2</sup>.



# **Pinning information**

Table 2. **Pinning information** 

| Pin | Symbol | Description | Simplified outline | Graphic symbol          |
|-----|--------|-------------|--------------------|-------------------------|
| 1   | S1     | source TR1  |                    |                         |
| 2   | G1     | gate TR1    | 6 5 4              | D1 D2                   |
| 3   | D2     | drain TR2   |                    |                         |
| 4   | S2     | source TR2  |                    | $G1 \longrightarrow G2$ |
| 5   | G2     | gate TR2    | 1 2 3              |                         |
| 6   | D1     | drain TR1   | SOT666             | S1 S2                   |
|     |        |             |                    | 017aaa260               |

#### **Ordering information** 3.

**Ordering information** Table 3.

| Type number | Package |  |         |  |
|-------------|---------|--|---------|--|
|             | Name    | Description                              | Version |  |
| PMDT670UPE  | -       | plastic surface-mounted package; 6 leads | SOT666  |  |

# **Marking**

Table 4. **Marking codes** 

| Type number | Marking code |
|-------------|--------------|
| PMDT670UPE  | AG           |

# **Limiting values**

**Limiting values** 

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol           | Parameter               | Conditions  |            | Min | Max  | Unit |
|------------------|-------------------------|---|------------|-----|------|------|
| Per transis      | stor                    |   |            |     |      |      |
| V <sub>DS</sub>  | drain-source voltage    | T <sub>j</sub> = 25 °C  |            | -   | -20  | V    |
| $V_{GS}$         | gate-source voltage     |   |            | -8  | 8    | V    |
| I <sub>D</sub>   | drain current           | $V_{GS} = -4.5 \text{ V}; T_{amb} = 25 \text{ °C}$                | <u>[1]</u> | -   | -550 | mΑ   |
|                  |                         | $V_{GS} = -4.5 \text{ V}; T_{amb} = 100 ^{\circ}\text{C}$         | <u>[1]</u> | -   | -350 | mΑ   |
| I <sub>DM</sub>  | peak drain current      | $T_{amb} = 25 \text{ °C}$ ; single pulse; $t_p \le 10 \text{ µs}$ |            | -   | -2.2 | Α    |
| P <sub>tot</sub> | total power dissipation | T <sub>amb</sub> = 25 °C  | [2]        | -   | 330  | mW   |
|                  |                         |   | <u>[1]</u> | -   | 390  | mW   |
|                  |                         | T <sub>sp</sub> = 25 °C   |            | -   | 1090 | mW   |
| Per device       |                         |   |            |     |      |      |
| P <sub>tot</sub> | total power dissipation | T <sub>amb</sub> = 25 °C  | [2]        | -   | 500  | mW   |
| Tj               | junction temperature    |   |            | -55 | 150  | °C   |
| T <sub>amb</sub> | ambient temperature     |   |            | -55 | 150  | °C   |

 Table 5.
 Limiting values ...continued

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol           | Parameter                       | Conditions               |            | Min | Max  | Unit |
|------------------|---------------------------------|--------------------------|------------|-----|------|------|
| T <sub>stg</sub> | storage temperature             |                          |            | -65 | 150  | °C   |
| Source-drain     | n diode                         |                          |            |     |      |      |
| Is               | source current                  | T <sub>amb</sub> = 25 °C | <u>[1]</u> | -   | -370 | mΑ   |
| ESD maximu       | um rating                       |                          |            |     |      |      |
| V <sub>ESD</sub> | electrostatic discharge voltage | HBM                      | [3]        | -   | 2000 | V    |

- [1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 1 cm<sup>2</sup>.
- [2] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.
- [3] Measured between all pins.

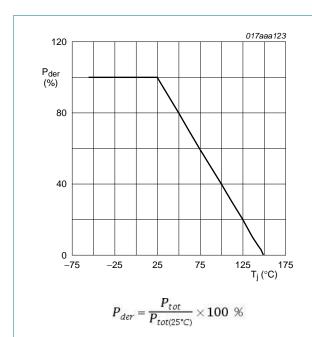


Fig 1. Normalized total power dissipation as a function of junction temperature

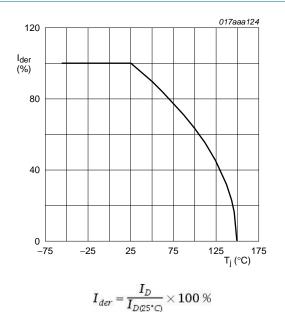
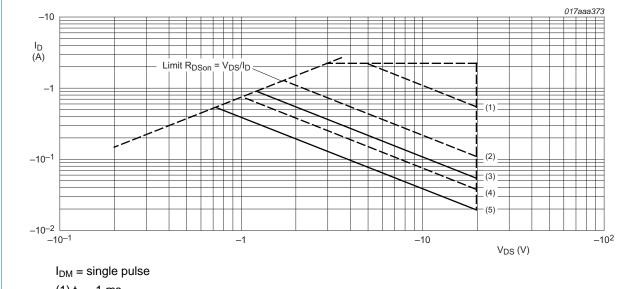


Fig 2. Normalized continuous drain current as a function of junction temperature



- (1)  $t_p = 1 \text{ ms}$
- (2)  $t_p = 10 \text{ ms}$
- (3) DC;  $T_{sp} = 25 \, ^{\circ}\text{C}$
- (4)  $t_p = 100 \text{ ms}$
- (5) DC; T<sub>amb</sub> = 25 °C; drain mounting pad 1 cm<sup>2</sup>

Fig 3. Safe operating area; junction to ambient; continuous and peak drain currents as a function of drain-source voltage

### 6. Thermal characteristics

Table 6. Thermal characteristics

| Symbol               | Parameter  | Conditions  |            | Min | Тур | Max | Unit |
|----------------------|--|-------------|------------|-----|-----|-----|------|
| Per device           |  |             |            |     |     |     |      |
| $R_{th(j-a)}$        | thermal resistance<br>from junction to<br>ambient      | in free air | <u>(1)</u> | -   | -   | 250 | K/W  |
| Per transistor       |  |             |            |     |     |     |      |
| R <sub>th(j-a)</sub> | thermal resistance                                     | in free air | <u>[1]</u> | -   | 330 | 380 | K/W  |
|                      | from junction to ambient                               |             | [2]        | -   | 280 | 320 | K/W  |
| $R_{th(j-sp)}$       | thermal resistance<br>from junction to solder<br>point |             |            | -   | -   | 115 | K/W  |

<sup>[1]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

<sup>[2]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated and mounting pad for drain 1 cm<sup>2</sup>.

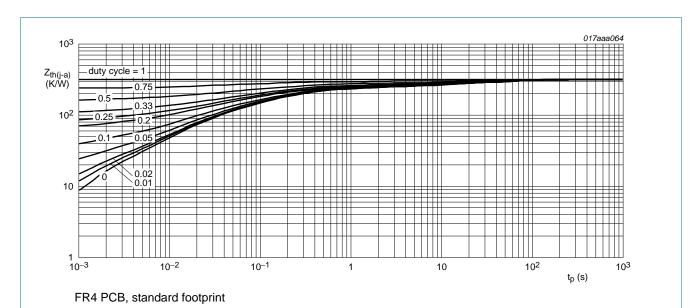


Fig 4. TR2: Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

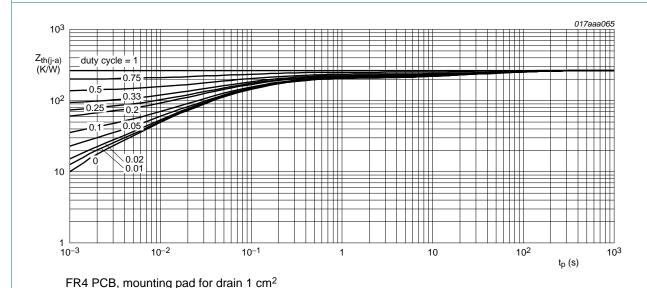


Fig 5. TR2: Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

## 7. Characteristics

Table 7. Characteristics

| Symbol              | Parameter                         | Conditions   | Min   | Тур   | Max  | Unit |
|---------------------|-----------------------------------|--|-------|-------|------|------|
| Static chara        | cteristics (per transistor)       |  |       |       |      |      |
| $V_{(BR)DSS}$       | drain-source<br>breakdown voltage | $I_D = -250 \mu A; V_{GS} = 0 V; T_j = 25 °C$                          | -20   | -     | -    | V    |
| $V_{GSth}$          | gate-source threshold voltage     | $I_D = -250 \ \mu A; \ V_{DS} = V_{GS}; \ T_j = 25 \ ^{\circ}C$        | -0.5  | -0.8  | -1.3 | V    |
| I <sub>DSS</sub>    | drain leakage current             | $V_{DS} = -20 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$    | -     | -     | -1   | μΑ   |
|                     |                                   | $V_{DS} = -20 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 150 \text{ °C}$   | -     | -     | -10  | μΑ   |
| $I_{GSS}$           | gate leakage current              | $V_{GS} = 8 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$      | -     | -     | -2   | μΑ   |
|                     |                                   | $V_{GS} = -8 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$     | -     | -     | -2   | μΑ   |
|                     |                                   | $V_{GS} = 4.5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$    | -     | -     | -0.5 | μΑ   |
|                     |                                   | $V_{GS} = -4.5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$   | -     | -     | -0.5 | μΑ   |
| R <sub>DSon</sub>   | drain-source on-state             | $V_{GS} = -4.5 \text{ V}; I_D = -400 \text{ mA}; T_j = 25 \text{ °C}$  | -     | 0.67  | 0.85 | Ω    |
|                     | resistance                        | $V_{GS} = -4.5 \text{ V}; I_D = -400 \text{ mA}; T_j = 150 \text{ °C}$ | -     | 1.1   | 1.4  | Ω    |
|                     |                                   | $V_{GS} = -2.5 \text{ V}; I_D = -200 \text{ mA}; T_j = 25 \text{ °C}$  | -     | 1.2   | 1.5  | Ω    |
|                     |                                   | $V_{GS} = -1.8 \text{ V}; I_D = -10 \text{ mA}; T_j = 25 \text{ °C}$   | -     | 1.8   | 2.8  | Ω    |
| 9 <sub>fs</sub>     | forward<br>transconductance       | $V_{DS}$ = -10 V; $I_{D}$ = -200 mA; $T_{j}$ = 25 °C                   | -     | 610   | -    | mS   |
| Dynamic ch          | aracteristics (per transist       | or)  |       |       |      |      |
| Q <sub>G(tot)</sub> | total gate charge                 | $V_{DS} = -10 \text{ V}; I_D = -400 \text{ mA};$                       | -     | 0.76  | 1.14 | nC   |
| Q <sub>GS</sub>     | gate-source charge                | $V_{GS} = -4.5 \text{ V}; T_j = 25 \text{ °C}$                         | -     | 0.28  | -    | nC   |
| $Q_{GD}$            | gate-drain charge                 |  | -     | 0.18  | -    | nC   |
| C <sub>iss</sub>    | input capacitance                 | $V_{DS} = -10 \text{ V}; f = 1 \text{ MHz}; V_{GS} = 0 \text{ V};$     | -     | 58    | 87   | pF   |
| C <sub>oss</sub>    | output capacitance                | T <sub>j</sub> = 25 °C   | -     | 21    | -    | pF   |
| C <sub>rss</sub>    | reverse transfer capacitance      |  | -     | 12    | -    | pF   |
| t <sub>d(on)</sub>  | turn-on delay time                | $V_{DS}$ = -10 V; $R_L$ = 250 $\Omega$ ; $V_{GS}$ = -4.5 V;            | -     | 18    | 36   | ns   |
| t <sub>r</sub>      | rise time                         | $R_{G(ext)} = 6 \Omega; T_j = 25 °C$                                   | -     | 30    | -    | ns   |
| $t_{d(off)}$        | turn-off delay time               |  | -     | 80    | 160  | ns   |
| t <sub>f</sub>      | fall time                         |  | -     | 72    | -    | ns   |
| Source-drai         | n diode (per transistor)          |  |       |       |      |      |
| $V_{SD}$            | source-drain voltage              | $I_S = -300 \text{ mA}; V_{GS} = 0 \text{ V}; T_i = 25 \text{ °C}$     | -0.48 | -0.84 | -1.2 | V    |

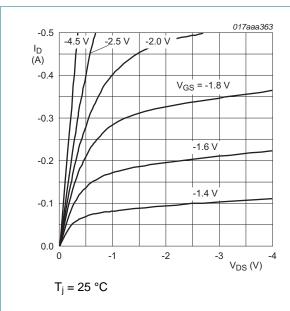
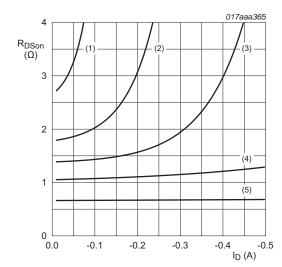


Fig 6. Output characteristics: drain current as a function of drain-source voltage; typical values



 $T_i = 25 \, ^{\circ}C$ 

(1)  $V_{GS} = -1.5 \text{ V}$ 

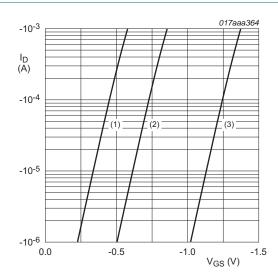
(2)  $V_{GS} = -1.8 \text{ V}$ 

(3)  $V_{GS} = -2.0 \text{ V}$ 

(4)  $V_{GS} = -2.5 \text{ V}$ 

(5)  $V_{GS} = -4.5 \text{ V}$ 

Fig 8. Drain-source on-state resistance as a function of drain current; typical values



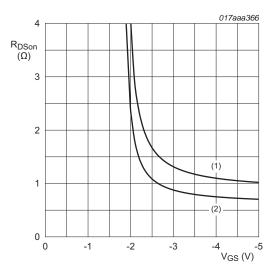
 $T_{j} = 25 \, ^{\circ}\text{C}; \, V_{DS} = -5 \, \text{V}$ 

(1) minimum values

(2) typical values

(3) maximum values

Fig 7. Sub-threshold drain current as a function of gate-source voltage

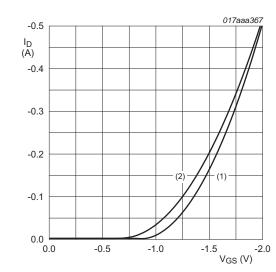


 $I_D = -400 \text{ mA}$ 

(1)  $T_i = 150 \, ^{\circ}C$ 

(2)  $T_i = 25 \, ^{\circ}C$ 

Fig 9. Drain-source on-state resistance as a function of gate-source voltage; typical values



 $V_{DS} > I_D \times R_{DSon}$ 

(1) 
$$T_j = 25 \, ^{\circ}C$$

(2)  $T_i = 150 \, ^{\circ}\text{C}$ 

Fig 10. Transfer characteristics: drain current as a function of gate-source voltage; typical values

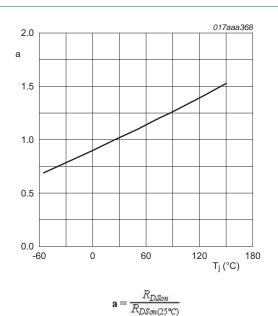
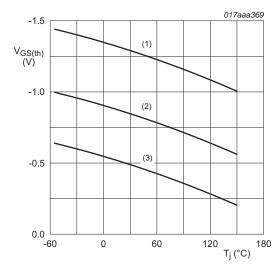


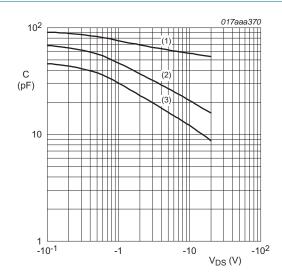
Fig 11. Normalized drain-source on-state resistance as a function of ambient temperature; typical values



 $I_D$  = -0.25 mA;  $V_{DS}$  =  $V_{GS}$ 

- (1) maximum values
- (2) typical values
- (3) minimum values

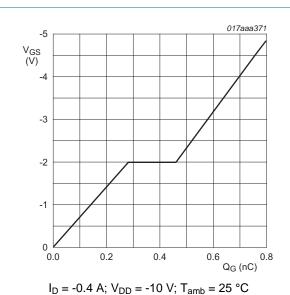
Fig 12. Gate-source threshold voltage as a function of junction temperature



 $f = 1 MHz; V_{GS} = 0 V$ 

- (1) C<sub>iss</sub>
- (2) C<sub>oss</sub>
- (3) C<sub>rss</sub>

Fig 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



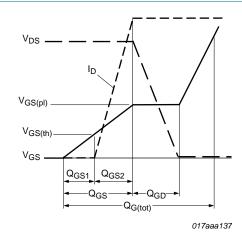
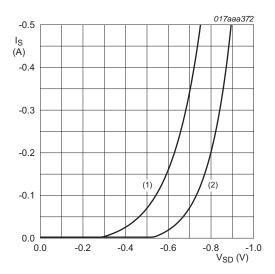


Fig 14. Gate-source voltage as a function of gate charge; typical values

Fig 15. Gate charge waveform definitions



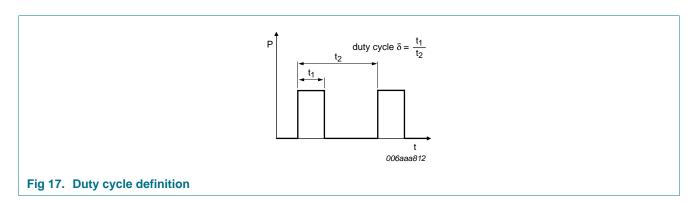
 $V_{GS} = 0 V$ 

(1)  $T_{amb} = 150 \, ^{\circ}C$ 

(2)  $T_{amb} = 25$  °C

Fig 16. Source current as a function of source-drain voltage; typical values

### 8. Test information



### 8.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard Q101 - Stress test qualification for discrete semiconductors, and is suitable for use in automotive applications.

**SOT666** 

detail X

2 mm

# 9. Package outline

Plastic surface-mounted package; 6 leads

# 

**DIMENSIONS** (mm are the original dimensions)

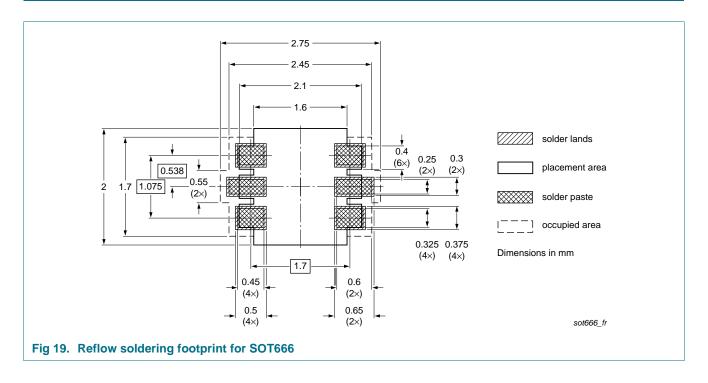
| UNIT | Α          | bp           | С            | D          | E          | е   | e <sub>1</sub> | HE         | L <sub>p</sub> | w   | у   |
|------|------------|--------------|--------------|------------|------------|-----|----------------|------------|----------------|-----|-----|
| mm   | 0.6<br>0.5 | 0.27<br>0.17 | 0.18<br>0.08 | 1.7<br>1.5 | 1.3<br>1.1 | 1.0 | 0.5            | 1.7<br>1.5 | 0.3<br>0.1     | 0.1 | 0.1 |

| OUTLINE |     | REFER | ENCES | EUROPEAN   | ISSUE DATE                        |
|---------|-----|-------|-------|------------|-----------------------------------|
| VERSION | IEC | JEDEC | JEITA | PROJECTION | ISSUE DATE                        |
| SOT666  |     |       |       |            | <del>-04-11-08-</del><br>06-03-16 |

Fig 18. Package outline SOT666

PMDT670UPE

# 10. Soldering





# 11. Revision history

### Table 8. Revision history

| Document ID    | Release date | Data sheet status  | Change notice | Supersedes |
|----------------|--------------|--------------------|---------------|------------|
| PMDT670UPE v.1 | 20110913     | Product data sheet | -             | -          |

### 12. Legal information

### 12.1 Data sheet status

| Document status [1] [2]        | Product status [3] | Definition  |
|--------------------------------|--------------------|---|
| Objective [short] data sheet   | Development        | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification      | This document contains data from the preliminary specification.                       |
| Product [short] data sheet     | Production         | This document contains the product specification.                                     |

- [1] Please consult the most recently issued document before initiating or completing a design
- [2] The term 'short data sheet' is explained in section "Definitions'
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PMDT670UPE

# PMDT670UPE

### 20 V, 550 mA dual P-channel Trench MOSFET

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# PMDT670UPE

### 20 V, 550 mA dual P-channel Trench MOSFET

### 14. Contents

| 1    | Product profile         | .1  |
|------|-------------------------|-----|
| 1.1  | General description     | .1  |
| 1.2  | Features and benefits   | . 1 |
| 1.3  | Applications            | .1  |
| 1.4  | Quick reference data    | .1  |
| 2    | Pinning information     | .2  |
| 3    | Ordering information    | .2  |
| 4    | Marking                 | .2  |
| 5    | Limiting values         | .2  |
| 6    | Thermal characteristics | .4  |
| 7    | Characteristics         | .6  |
| 8    | Test information        | 10  |
| 8.1  | Quality information     | 10  |
| 9    | Package outline         | 11  |
| 10   | Soldering               | 12  |
| 11   | Revision history        | 13  |
| 12   | Legal information       | 14  |
| 12.1 | Data sheet status       | 14  |
| 12.2 | Definitions             | 14  |
| 12.3 | Disclaimers             | 14  |
| 12.4 | Trademarks              | 15  |
| 13   | Contact information     | 15  |

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